Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,790	TOGAWA, YOSHIFUSA	
Examiner	Art Unit	
Eric Chang	2116	

SEARCHED			
Class	Subclass	Date	Examiner
713	320	1/5/2008	EC
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
713	320	1/5/2008	EC
PGPUB to	ext search	1/5/2008	EC

SEARCH N (INCLUDING SEAR)		·)
	DATE	EXMR
EAST USPAT/PGPUB EPO/JPO	1/5/2008	EC
EAST keyword search in 713/320	1/5/2008	EC
Inventor name search	1/5/2008	EC